

# FCC PART 15B, CLASS B TEST REPORT

For

**SWAGTEK**

10205 NW 19th Street STE101, Miami, Florida 33172 United States

**FCC ID: O55X4422A**

<b>Report Type:</b> Original Report	<b>Product Type:</b> Smart Phone
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<b>Report Number:</b> RSZ150906006-00A	
<b>Report Date:</b> 2015-09-21	
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**Note:** This test report is prepared for the customer shown above and for the device described herein. It may not be duplicated or used in part without prior written consent from Bay Area Compliance Laboratories Corp.

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## GENERAL INFORMATION

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### Product Description for Equipment under Test (EUT)

The SWAGTEK's product, model number: X4 (FCC ID: O55X4422A) or the "EUT" in this report was a *Smart Phone*, which was measured approximately: 126 mm (L) × 63 mm (W) × 10 mm (H), rated with input voltage: DC 3.7 V Li-ion battery or DC 5 V from adapter. The highest operating frequency is 1000 MHz.

#### Adapter Information:

Input: AC100~240V; 50/60Hz, 0.15A

Output: DC 5V, 750mA

*Note: This series products model: X4plus, X40E, Ruby, Gem, V4 and X4 are identical schematics, the difference among them is just the model number due to marketing purpose, and model X4 was selected for fully testing, the detailed information can be referred to the attached declaration letter that stated and guaranteed by the applicant.*

*\*All measurement and test data in this report was gathered from production sample serial number: 1506317 (Assigned by Shenzhen BACL). The EUT supplied by the applicant was received on 2015-09-06.*

### Objective

This test report is prepared on behalf of SWAGTEK in accordance with Part 2-Subpart J, Part 15-Subparts A and B of the Federal Communication Commissions rules.

The objective of the manufacturer is to determine the compliance of the EUT with FCC Part 15 B.

### Related Submittal(s)/Grant(s)

FCC Part 15.247 DTS & DSS and Part 22H/24E PCE submissions with FCC ID: O55X4422A

### Test Facility

The test site used by Bay Area Compliance Laboratories Corp. (Shenzhen) to collect test data is located on the 6/F, the 3rd Phase of WanLi Industrial Building, ShiHua Road, FuTian Free Trade Zone Shenzhen, Guangdong, China.

Test site at Bay Area Compliance Laboratories Corp. (Shenzhen) has been fully described in reports submitted to the Federal Communication Commission (FCC). The details of these reports have been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on October 31, 2013. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-2009.

The Federal Communications Commission has the reports on file and is listed under FCC Registration No.: 382179. The test site has been approved by the FCC for public use and is listed in the FCC Public Access Link (PAL) database.

## SYSTEM TEST CONFIGURATION

### Description of Test Configuration

The system was configured for testing in a manufacturer testing fashion.

EUT operation mode: Downloading (data transfer with computer)

### EUT Exercise Software

“BurnIn test v5.3” exercise software was used.

### Special Accessories

No special accessory.

### Equipment Modifications

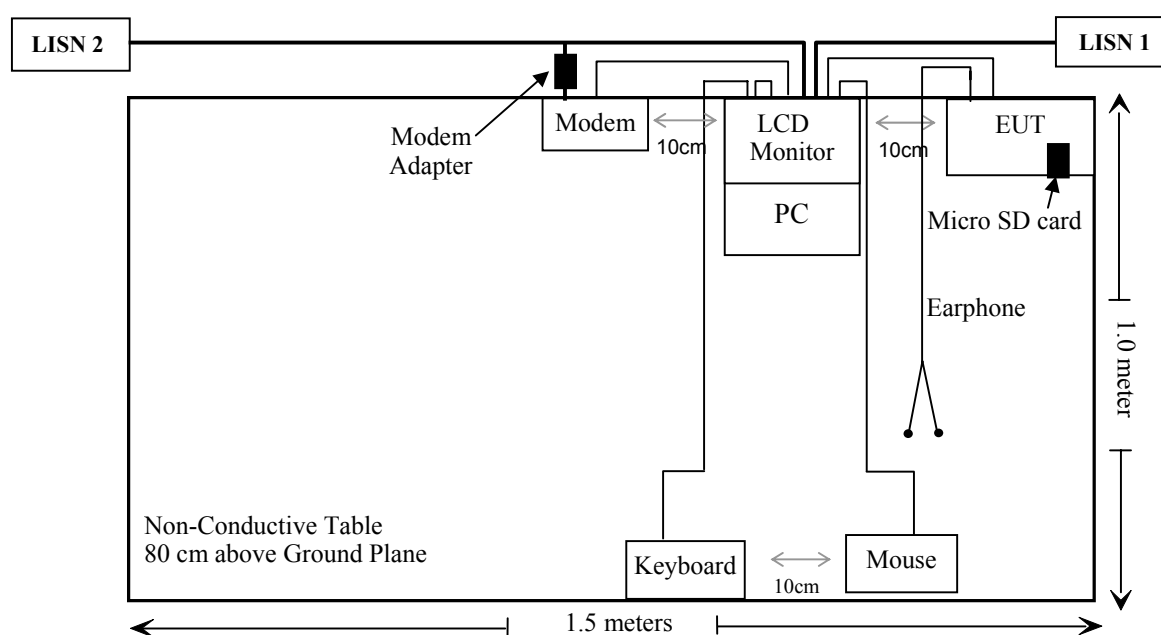
No modification was made to the EUT tested.

### Support Equipment List and Details

Manufacturer	Description	Model	Serial Number
DELL	PC	VOSTRO 220S	127BP2X
DELL	LCD Monitor	E178WFPC	CN-OWY564-64180-7C4-2SQH
DELL	Keyboard	L100	CNORH656658907BL05DC
DELL	Mouse	MOC5UO	G1900NKD
SAST	Modem	AEM-2100	0293
Kingston	Micro SD card	4 GB	N/A
PHILIPS	Earphone	SBCHP250	N/A

**External I/O Cable**

Cable Description	Length (m)	From/Port	To
Un-Shielding Detachable USB Cable	1.5	Host PC	Mouse
Un-Shielding Detachable Serial Cable	1.5	Host PC	Modem
Un-Shielding Detachable K/B Cable	1.5	Host PC	Keyboard
Un-Shielding Detachable VGA Cable	1.5	Host PC	LCD Monitor
Shielding Detachable Earphone Cable	0.9	EUT	Earphone
Un-shielding Detachable USB Cable	1.0	EUT	PC
Un-shielding Detachable USB Cable	1.0	Modem	Modem Adapter

**Block Diagram of Test Setup**

**SUMMARY OF TEST RESULTS**

FCC Rules	Description of Test	Results
§15.107	AC Line Conducted Emissions	Compliance
§15.109	Radiated Spurious Emissions	Compliance

## FCC §15.107 – AC LINE CONDUCTED EMISSIONS

### Applicable Standard

According to FCC §15.107

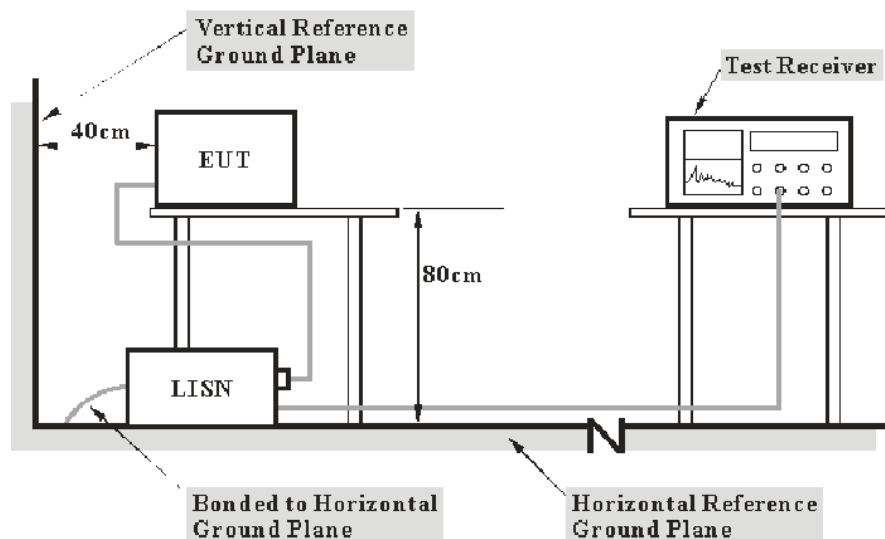
### Measurement Uncertainty

Input quantities to be considered for conducted disturbance measurements maybe receiver reading, attenuation of the connection between LISN/ISN and receiver, LISN/ISN voltage division factor, LISN/ISN VDF frequency interpolation and receiver related input quantities, etc.

Based on CISPR 16-4-2:2011, the expended combined standard uncertainty of conducted disturbance test at Bay Area Compliance Laboratories Corp. (Shenzhen) is shown as below. And the uncertainty will not be taken into consideration for the test data recorded in the report

Port	Measurement uncertainty
AC Mains	3.26 dB (k=2, 95% level of confidence)
CAT 3	3.70 dB (k=2, 95% level of confidence)
CAT 5	3.86 dB (k=2, 95% level of confidence)
CAT 6	4.64 dB (k=2, 95% level of confidence)

### EUT Setup



- Note: 1. Support units were connected to second LISN.  
2. Both of LISNs (AMN) 80 cm from EUT and at the least 80 cm from other units and other metal planes support units.

The measurement procedure of EUT setup is according with per ANSI C63.4-2009. The related limit was specified in FCC Part 15.107 Class B.

The spacing between the peripherals was 10 cm.

The host PC, LCD Monitor and Modem Adapter were connected to a 120 VAC/60 Hz power source.

## EMI Test Receiver Setup

The EMI test receiver was set to investigate the spectrum from 150 kHz to 30 MHz.

During the conducted emission test, the EMI test receiver was set with the following configurations:

Frequency Range	IF B/W
150 kHz – 30 MHz	9 kHz

## Test Procedure

During the conducted emission test, the host PC was connected to the first LISN and the other relevant equipments were connected to the second LISN.

Maximizing procedure was performed on the six (6) highest emissions of the EUT.

All data was recorded in the Quasi-peak and average detection mode.

## Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
Rohde & Schwarz	EMI Test Receiver	ESCS30	100176	2015-06-03	2016-06-03
Rohde & Schwarz	LISN	ENV216	3560.6650.12-101613-Yb	2014-12-01	2015-12-01
Rohde & Schwarz	LISN	ESH2-Z5	892107/021	2015-06-09	2016-06-09
Rohde & Schwarz	Transient Limiter	ESH3Z2	DE25985	2015-05-14	2016-05-14
Rohde & Schwarz	CE Test software	EMC 32	V8.53	NCR	NCR

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Shenzhen) attests that all calibrations have been performed in accordance to requirements that traceable to National Primary Standards and International System of Units (SI).

## Corrected Factor & Margin Calculation

The Corrected factor is calculated by adding LISN/ISN VDF (Voltage Division Factor), Cable Loss and Transient Limiter Attenuation. The basic equation is as follows:

$$\text{Correction Factor} = \text{LISN VDF} + \text{Cable Loss} + \text{Transient Limiter Attenuation}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of 7 dB means the emission is 7 dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$



## Test Results Summary

According to the recorded data in following table, the EUT complied with the FCC Part 15.107, the worst margin as below:

**7.6 dB at 24.247190 MHz in the Neutral conducted mode**

Refer to CISPR16-4-2:2011 and CISPR 16-4-1:2009, the measured level is in compliance with the limit if

$$L_m + U_{(Lm)} \leq L_{lim} + U_{cispr}$$

In BACL.,  $U_{(Lm)}$  is less than  $U_{cispr}$ , if  $L_m$  is less than  $L_{lim}$ , it implies that the EUT complies with the limit.

## Test Data

### Environmental Conditions

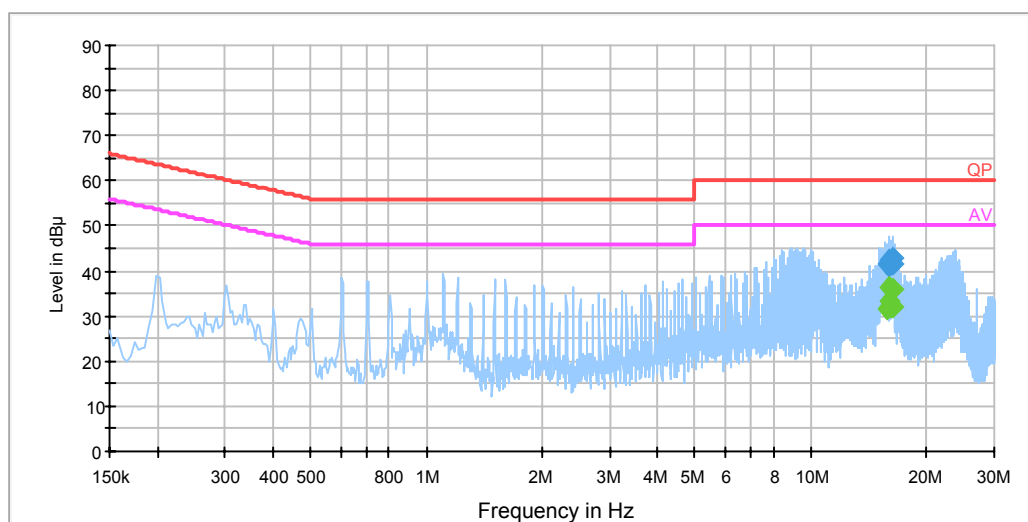
<b>Temperature:</b>	26 °C
<b>Relative Humidity:</b>	50 %
<b>ATM Pressure:</b>	101.0 kPa

*The testing was performed by Mike Hu on 2015-09-16.*

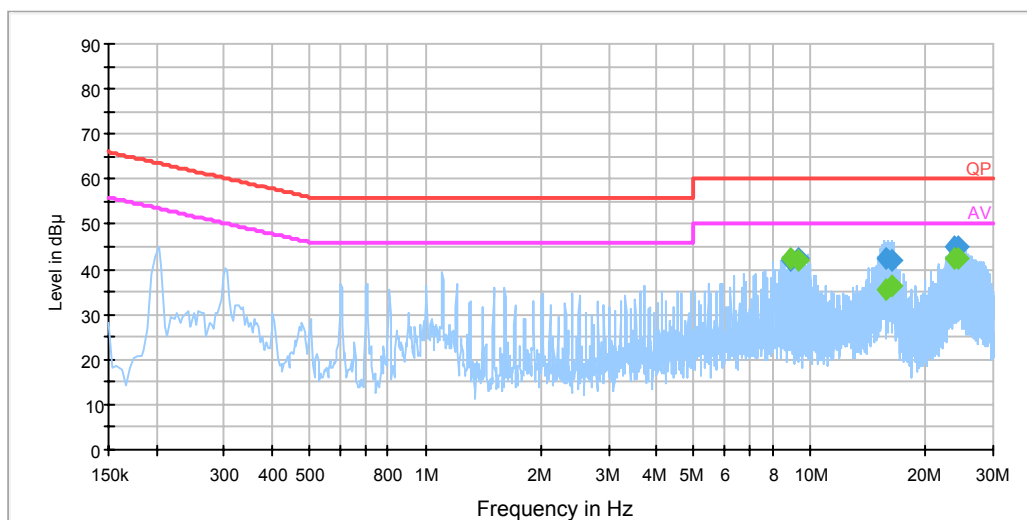
*EUT Operation Mode: Downloading*

**AC 120V/60 Hz, Line**

EMI Auto Test L



Frequency (MHz)	Corrected Amplitude (dBμV)	Correction Factor (dB)	Limit (dBμV)	Margin (dB)	Detector (PK/Ave./QP)
15.875010	41.6	20.1	60.0	18.4	QP
15.875010	31.8	20.1	50.0	18.2	Ave.
15.955030	42.3	20.1	60.0	17.7	QP
15.955030	36.3	20.1	50.0	13.7	Ave.
15.959410	41.2	20.1	60.0	18.8	QP
15.959410	33.2	20.1	50.0	16.8	Ave.
16.230090	41.5	20.1	60.0	18.5	QP
16.230090	32.0	20.1	50.0	18.0	Ave.
16.338410	42.8	20.1	60.0	17.2	QP
16.338410	35.7	20.1	50.0	14.3	Ave.
16.348390	41.6	20.1	60.0	18.4	QP
16.348390	32.1	20.1	50.0	17.9	Ave.

**AC 120V/60 Hz, Neutral****EMI Auto Test N**

Frequency (MHz)	Corrected Amplitude (dBμV)	Correction Factor (dB)	Limit (dBμV)	Margin (dB)	Detector (PK/Ave./QP)
8.954130	42.2	20.1	60.0	17.8	QP
8.954130	42.2	20.1	50.0	7.8	Ave.
9.356130	42.2	20.1	60.0	17.8	QP
9.356130	41.9	20.1	50.0	8.1	Ave.
15.855190	42.3	20.1	60.0	17.7	QP
15.855190	35.6	20.1	50.0	14.4	Ave.
16.384630	41.8	20.1	60.0	18.2	QP
16.384630	36.4	20.1	50.0	13.6	Ave.
23.643310	45.2	20.1	60.0	14.8	QP
23.643310	42.3	20.1	50.0	7.7	Ave.
24.247190	44.9	20.1	60.0	15.1	QP
24.247190	42.4	20.1	50.0	7.6	Ave.

**Note:**

- 1) Correction Factor = LISN VDF (Voltage Division Factor) + Cable Loss + Transient Limiter Attenuation  
The corrected factor has been input into the transducer of the test software.
- 2) Corrected Amplitude = Reading + Correction Factor
- 3) Margin = Limit – Corrected Amplitude

## FCC §15.109 - RADIATED SPURIOUS EMISSIONS

### Applicable Standard

FCC §15.109

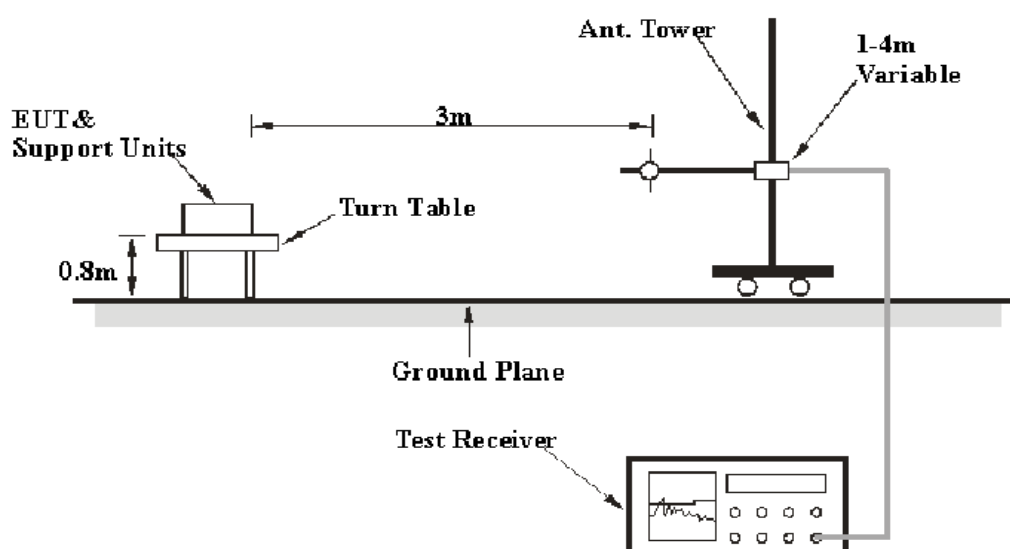
### Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on CISPR 16-4-2:2011, the expanded combined standard uncertainty of radiation emissions at Bay Area Compliance Laboratories Corp. (Shenzhen) is shown in below table. And the uncertainty will not be taken into consideration for the test data recorded in the report

Frequency	Polarity	Measurement uncertainty
30 MHz~200 MHz	Horizontal	4.62 dB (k=2, 95% level of confidence)
	Vertical	4.54 dB (k=2, 95% level of confidence)
200 MHz~1 GHz	Horizontal	4.84 dB (k=2, 95% level of confidence)
	Vertical	5.91 dB (k=2, 95% level of confidence)
1 GHz~6 GHz	Horizontal/Vertical	4.68 dB (k=2, 95% level of confidence)
Above 6 GHz	Horizontal/Vertical	4.92 dB (k=2, 95% level of confidence)

### EUT Setup



The radiated emission tests were performed in the 3 meters chamber test site, using the setup accordance with the ANSI C63.4-2009. The specification used was the FCC Part 15.109 Class B limits.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The spacing between the peripherals was 10 cm.

The host PC, LCD Monitor and Modem Adapter were connected to a 120 VAC/60 Hz power source.

### EMI Test Receiver Setup

The system was investigated from 30 MHz to 5 GHz.

During the radiated emission test, the EMI test receiver was set with the following configurations:

Frequency Range	RBW	Video B/W	IF B/W	Detector
30 MHz – 1000 MHz	100 kHz	300 kHz	120 kHz	QP
Above 1 GHz	1MHz	3 MHz	/	PK
	1MHz	10 Hz	/	Ave.

### Test Procedure

Maximizing procedure was performed on the highest emissions to ensure that the EUT complied with all installation combinations.

All data was recorded in the Quasi-peak detector mode from 30 MHz to 1 GHz and PK and average detector modes for frequencies above 1 GHz.

### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
HP	Amplifier	HP8447E	1937A01046	2015-05-06	2016-05-06
Rohde & Schwarz	EMI Test Receiver	ESCI	101120	2014-11-03	2015-11-03
Sunol Sciences	Bi-log Antenna	JB1	A040904-2	2014-12-07	2017-12-06
A.H. System	Horn Antenna	SAS-200/571	135	2015-02-10	2018-02-10
Rohde & Schwarz	Signal Analyzer	FSIQ26	8386001028	2014-12-11	2015-12-11
Mini	Pre-amplifier	ZVA-183-S+	5969001149	2015-04-23	2016-04-23
TDK	Chamber	Chamber A	2#	2012-10-15	2015-10-15
TDK	Chamber	Chamber B	1#	2015-07-22	2018-07-22
R&S	Auto test Software	EMC32	V9.10	NCR	NCR

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Shenzhen) attests that all calibrations have been performed in accordance to requirements that traceable to National Primary Standards and International System of Units (SI).

## Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Loss, and subtracting the Amplifier Gain from the Meter Reading. The basic equation is as follows:

$$\text{Corrected Amplitude} = \text{Meter Reading} + \text{Antenna Factor} + \text{Cable Loss} - \text{Amplifier Gain}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of 7 dB means the emission is 7 dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$

## Test Results Summary

According to the data in the following table, the EUT complied with the FCC §15.109 Class B, the worst margin reading as below:

**4.89 dB at 246.16 MHz in the Horizontal polarization mode**

Refer to CISPR16-4-2:2011 and CISPR 16-4-1:2009, the measured level is in compliance with the limit if

$$L_m + U_{(Lm)} \leq L_{lim} + U_{cispr}$$

In BACL,  $U_{(Lm)}$  is less than  $U_{cispr}$ , if  $L_m$  is less than  $L_{lim}$ , it implies that the EUT complies with the limit.

## Test Data

### Environmental Conditions

<b>Temperature:</b>	26 °C
<b>Relative Humidity:</b>	50 %
<b>ATM Pressure:</b>	101.0 kPa

*The testing was performed by Mike Hu on 2015-09-16.*

*EUT Operation Mode: Downloading***30 MHz – 5 GHz**

Frequency (MHz)	Receiver		Turntable Degree	Rx Antenna		Corrected Factor (dB/m)	Corrected Amplitude (dBμV/m)	FCC Part 15B	
	Reading (dBμV)	Detector (PK/QP/Ave.)		Height (m)	Polar (H/V)			Limit (dBμV/m)	Margin (dB)
205.84	45.49	QP	89	1.7	H	-15.6	30.89	43.5	12.61
242.79	54.30	QP	83	1.3	H	-14.7	39.60	46	6.40
246.16	55.71	QP	88	1.7	H	-14.6	41.11	46	4.89
319.00	49.20	QP	66	1.1	H	-12.0	37.20	46	8.80
480.00	40.71	QP	133	1.4	V	-8.6	32.11	46	13.89
697.08	37.62	QP	34	1.4	V	-5.5	32.12	46	13.88
1721.82	39.56	PK	238	2.1	V	1.08	40.64	74	33.36
1721.82	20.09	Ave.	238	2.1	V	1.08	21.17	54	32.83

Note:

- 1) Correction Factor=Antenna factor (RX) + cable loss – amplifier factor
- 2) Corrected Amplitude = Correction Factor + Reading
- 3) Margin = Limit - Corrected Amplitude

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## **PRODUCT SIMILARITY DECLARATION LETTER**

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SWAGTEK  
10205 NW 19th Street STE101, Miami, Florida 33172 United States  
Tel: 1-305 421 9938 Fax: 1-305 471 9011

2015-9-18

### **Product Similarity Declaration**

To Whom It May Concern,

We, SWAGTEK, hereby declare that we have a product named as Smart Phone(Model number: X4) was tested by BACL, meanwhile, for our marketing purpose, we would like to list a series models (X4plus;X40E;Ruby;Gem;V4) on reports and certificate, only the model name are difference. No other changes are made to them.

We confirm that all information above is true, and we'll be responsible for all the consequences. Please contact me if you have any question.

Signature:



Charles Cheng

Manager

**\*\*\*\*\* END OF REPORT \*\*\*\*\***